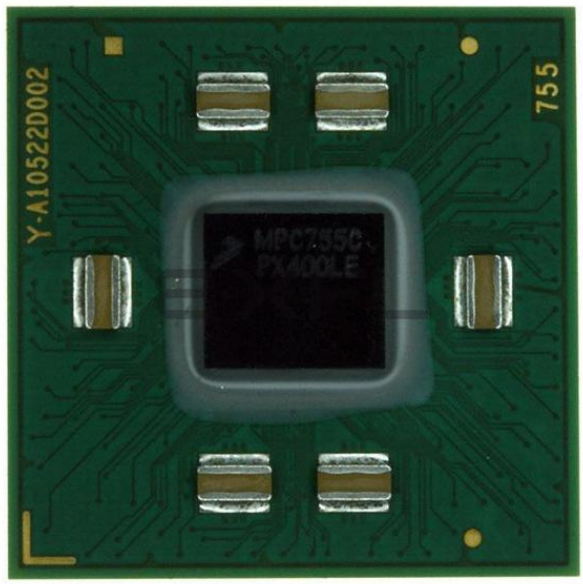

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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	400MHz
Co-Processors/DSP	-
RAM Controllers	-
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	-
SATA	-
USB	-
Voltage - I/O	2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	360-BBGA, FCBGA
Supplier Device Package	360-FCPBGA (25x25)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc755cpx400ler2

2 Features

This section summarizes features of the MPC755 implementation of the PowerPC architecture. Major features of the MPC755 are as follows:

- Branch processing unit
  - Four instructions fetched per clock
  - One branch processed per cycle (plus resolving two speculations)
  - Up to one speculative stream in execution, one additional speculative stream in fetch
  - 512-entry branch history table (BHT) for dynamic prediction
  - 64-entry, four-way set-associative branch target instruction cache (BTIC) for eliminating branch delay slots
- Dispatch unit
  - Full hardware detection of dependencies (resolved in the execution units)
  - Dispatch two instructions to six independent units (system, branch, load/store, fixed-point unit 1, fixed-point unit 2, floating-point)
  - Serialization control (predispatch, postdispatch, execution serialization)
- Decode
  - Register file access
  - Forwarding control
  - Partial instruction decode
- Completion
  - Six-entry completion buffer
  - Instruction tracking and peak completion of two instructions per cycle
  - Completion of instructions in program order while supporting out-of-order instruction execution, completion serialization, and all instruction flow changes
- Fixed point units (FXUs) that share 32 GPRs for integer operands
  - Fixed Point Unit 1 (FXU1)—multiply, divide, shift, rotate, arithmetic, logical
  - Fixed Point Unit 2 (FXU2)—shift, rotate, arithmetic, logical
  - Single-cycle arithmetic, shifts, rotates, logical
  - Multiply and divide support (multi-cycle)
  - Early out multiply
- Floating-point unit and a 32-entry FPR file
  - Support for IEEE standard 754 single- and double-precision floating-point arithmetic
  - Hardware support for divide
  - Hardware support for denormalized numbers
  - Single-entry reservation station
  - Supports non-IEEE mode for time-critical operations
  - Three-cycle latency, one-cycle throughput, single-precision multiply-add

  - Three-cycle latency, one-cycle throughput, double-precision add
  - Four-cycle latency, two-cycle throughput, double-precision multiply-add
- System unit
  - Executes CR logical instructions and miscellaneous system instructions
  - Special register transfer instructions
- Load/store unit
  - One-cycle load or store cache access (byte, half-word, word, double word)
  - Effective address generation
  - Hits under misses (one outstanding miss)
  - Single-cycle unaligned access within double-word boundary
  - Alignment, zero padding, sign extend for integer register file
  - Floating-point internal format conversion (alignment, normalization)
  - Sequencing for load/store multiples and string operations
  - Store gathering
  - Cache and TLB instructions
  - Big- and little-endian byte addressing supported
- Level 1 cache structure
  - 32K, 32-byte line, eight-way set-associative instruction cache (iL1)
  - 32K, 32-byte line, eight-way set-associative data cache (dL1)
  - Cache locking for both instruction and data caches, selectable by group of ways
  - Single-cycle cache access
  - Pseudo least-recently-used (PLRU) replacement
  - Copy-back or write-through data cache (on a page per page basis)
  - MEI data cache coherency maintained in hardware
  - Nonblocking instruction and data cache (one outstanding miss under hits)
  - No snooping of instruction cache
- Level 2 (L2) cache interface (not implemented on MPC745)
  - Internal L2 cache controller and tags; external data SRAMs
  - 256K, 512K, and 1 Mbyte two-way set-associative L2 cache support
  - Copy-back or write-through data cache (on a page basis, or for all L2)
  - Instruction-only mode and data-only mode
  - 64-byte (256K/512K) or 128-byte (1M) sectored line size
  - Supports flow through (register-buffer) synchronous BurstRAMs, pipelined (register-register) synchronous BurstRAMs (3-1-1-1 or strobeless 4-1-1-1) and pipelined (register-register) late write synchronous BurstRAMs
  - L2 configurable to cache, private memory, or split cache/private memory
  - Core-to-L2 frequency divisors of ÷1, ÷1.5, ÷2, ÷2.5, and ÷3 supported
  - 64-bit data bus

Table 3 provides the recommended operating conditions for the MPC755.

Table 3. Recommended Operating Conditions [1]

Characteristic		Symbol	Recommended Value				Unit	Notes
			300 MHz, 350 MHz		400 MHz			
			Min	Max	Min	Max		
Core supply voltage		V_{DD}	1.80	2.10	1.90	2.10	V	3
PLL supply voltage		AV_{DD}	1.80	2.10	1.90	2.10	V	3
L2 DLL supply voltage		$L2AV_{DD}$	1.80	2.10	1.90	2.10	V	3
Processor bus supply voltage	BVSEL = 1	OV_{DD}	2.375	2.625	2.375	2.625	V	2, 4
			3.135	3.465	3.135	3.465		5
L2 bus supply voltage	L2VSEL = 1	$L2OV_{DD}$	2.375	2.625	2.375	2.625	V	2, 4
			3.135	3.465	3.135	3.465		5
Input voltage	Processor bus	V_{in}	GND	OV_{DD}	GND	OV_{DD}	V	
	L2 bus	V_{in}	GND	$L2OV_{DD}$	GND	$L2OV_{DD}$	V	
	JTAG signals	V_{in}	GND	OV_{DD}	GND	OV_{DD}	V	
Die-junction temperature		T_j	0	105	0	105	°C	

Notes:

1. These are the recommended and tested operating conditions. Proper device operation outside of these conditions is not guaranteed.
2. Revisions prior to Rev. 2.8 (Rev. E) offered different I/O voltage support. For more information, refer to Section 10.2, “Part Numbers Not Fully Addressed by This Document.”
3. 2.0 V nominal.
4. 2.5 V nominal.
5. 3.3 V nominal.

Table 4 provides the package thermal characteristics for the MPC755 and MPC745. The MPC755 was initially sampled in a CBGA package, but production units are currently provided in both a CBGA and a PBGA package. Because of the better long-term device-to-board interconnect reliability of the PBGA package, Freescale recommends use of a PBGA package except where circumstances dictate use of a CBGA package. The MPC745 is offered in a PBGA package only.

Table 6. DC Electrical Specifications (continued)

At recommended operating conditions (see Table 3)

Characteristic	Nominal Bus Voltage [1]	Symbol	Min	Max	Unit	Notes
Capacitance, V_{in} = 0 V, f = 1 MHz		C_{in}	—	5.0	pF	3, 4

Notes:

1. Nominal voltages; see Table 3 for recommended operating conditions.
2. For processor bus signals, the reference is OV_{DD} while $L2OV_{DD}$ is the reference for the L2 bus signals.
3. Excludes test signals (LSSD_MODE, L1_TSTCLK, L2_TSTCLK) and IEEE 1149.1 boundary scan (JTAG) signals.
4. Capacitance is periodically sampled rather than 100% tested.
5. The leakage is measured for nominal OV_{DD} and V_{DD}, or both OV_{DD} and V_{DD} must vary in the same direction (for example, both OV_{DD} and V_{DD} vary by either +5% or –5%).

Table 7 provides the power consumption for the MPC755.

Table 7. Power Consumption for MPC755

	Processor (CPU) Frequency			Unit	Notes
	300 MHz	350 MHz	400 MHz		
Full-Power Mode					
Typical	3.1	3.6	5.4	W	1, 3, 4
Maximum	4.5	6.0	8.0	W	1, 2
Doze Mode					
Maximum	1.8	2.0	2.3	W	1, 2, 4
Nap Mode					
Maximum	1.0	1.0	1.0	W	1, 2, 4
Sleep Mode					
Maximum	550	550	550	mW	1, 2, 4
Sleep Mode (PLL and DLL Disabled)					
Maximum	510	510	510	mW	1, 2

Notes:

1. These values apply for all valid processor bus and L2 bus ratios. The values do not include I/O supply power (OV_{DD} and $L2OV_{DD}$) or PLL/DLL supply power (AV_{DD} and $L2AV_{DD}$). OV_{DD} and $L2OV_{DD}$ power is system dependent, but is typically <10% of V_{DD} power. Worst case power consumption for AV_{DD} = 15 mW and $L2AV_{DD}$ = 15 mW.
2. Maximum power is measured at nominal V_{DD} (see Table 3) while running an entirely cache-resident, contrived sequence of instructions which keep the execution units maximally busy.
3. Typical power is an average value measured at the nominal recommended V_{DD} (see Table 3) and 65°C in a system while running a typical code sequence.
4. Not 100% tested. Characterized and periodically sampled.

SRAM. Note that revisions of the MPC755 prior to Rev. 2.8 (Rev. E) were limited in performance, and were typically limited to 175 MHz with similarly-rated SRAM. For more information, see Section 10.2, “Part Numbers Not Fully Addressed by This Document.”

Freescale is similarly limited by system constraints and cannot perform tests of the L2 interface on a socketed part on a functional tester at the maximum frequencies of Table 11. Therefore, functional operation and AC timing information are tested at core-to-L2 divisors of 2 or greater. Functionality of core-to-L2 divisors of 1 or 1.5 is verified at less than maximum rated frequencies.

L2 input and output signals are latched or enabled, respectively, by the internal L2CLK (which is SYSCLK multiplied up to the core frequency and divided down to the L2CLK frequency). In other words, the AC timings of Table 12 and Table 13 are entirely independent of L2SYNC_IN. In a closed loop system, where L2SYNC_IN is driven through the board trace by L2SYNC_OUT, L2SYNC_IN only controls the output phase of L2CLK_OUTA and L2CLK_OUTB which are used to latch or enable data at the SRAMs. However, since in a closed loop system L2SYNC_IN is held in phase alignment with the internal L2CLK, the signals of Table 12 and Table 13 are referenced to this signal rather than the not-externally-visible internal L2CLK. During manufacturing test, these times are actually measured relative to SYSCLK.

The L2SYNC_OUT signal is intended to be routed halfway out to the SRAMs and then returned to the L2SYNC_IN input of the MPC755 to synchronize L2CLK_OUT at the SRAM with the processor’s internal clock. L2CLK_OUT at the SRAM can be offset forward or backward in time by shortening or lengthening the routing of L2SYNC_OUT to L2SYNC_IN. See Freescale Application Note AN1794/D, *Backside L2 Timing Analysis for PCB Design Engineers*.

The L2CLK_OUTA and L2CLK_OUTB signals should not have more than two loads.

Table 11. L2CLK Output AC Timing Specification

At recommended operating conditions (see Table 3)

Parameter	Symbol	All Speed Grades		Unit	Notes
		Min	Max		
L2CLK frequency	f_{L2CLK}	80	450	MHz	1, 4
L2CLK cycle time	t_{L2CLK}	2.5	12.5	ns	
L2CLK duty cycle	t_{CHCL}/t_{L2CLK}	45	55	%	2, 7
Internal DLL-relock time		640	—	L2CLK	3, 7
DLL capture window		0	10	ns	5, 7
L2CLK_OUT output-to-output skew	t_{L2CSKW}	—	50	ps	6, 7
L2CLK_OUT output jitter		—	±150	ps	6, 7

Notes:

1. L2CLK outputs are L2CLK_OUTA, L2CLK_OUTB, L2CLK_OUT, and L2SYNC_OUT pins. The L2CLK frequency-to-core frequency settings must be chosen such that the resulting L2CLK frequency and core frequency do not exceed their respective maximum or minimum operating frequencies. The maximum L2LCK frequency will be system dependent. L2CLK_OUTA and L2CLK_OUTB must have equal loading.
2. The nominal duty cycle of the L2CLK is 50% measured at midpoint voltage.
3. The DLL-relock time is specified in terms of L2CLK periods. The number in the table must be multiplied by the period of L2CLK to compute the actual time duration in ns. Relock timing is guaranteed by design and characterization.
4. The L2CR[L2SL] bit should be set for L2CLK frequencies less than 110 MHz. This adds more delay to each tap of the DLL.
5. Allowable skew between L2SYNC_OUT and L2SYNC_IN.
6. This output jitter number represents the maximum delay of one tap forward or one tap back from the current DLL tap as the phase comparator seeks to minimize the phase difference between L2SYNC_IN and the internal L2CLK. This number must be comprehended in the L2 timing analysis. The input jitter on SYSCLK affects L2CLK_OUT and the L2 address/data/control signals equally and, therefore, is already comprehended in the AC timing and does not have to be considered in the L2 timing analysis.
7. Guaranteed by design.

Table 12. L2 Bus Interface AC Timing Specifications (continued)

At recommended operating conditions (see Table 3)

Parameter	Symbol	All Speed Grades		Unit	Notes
		Min	Max		
L2SYNC_IN to high impedance: All outputs when L2CR[14–15] = 00 All outputs when L2CR[14–15] = 01 All outputs when L2CR[14–15] = 10 All outputs when L2CR[14–15] = 11	t_{L2CHOZ}	 — — — —	 2.4 2.6 2.8 3.0	ns	3, 5

Notes:

1. Rise and fall times for the L2SYNC_IN input are measured from 20% to 80% of $L2OV_{DD}$.
2. All input specifications are measured from the midpoint of the signal in question to the midpoint voltage of the rising edge of the input L2SYNC_IN (see Figure 8). Input timings are measured at the pins.
3. All output specifications are measured from the midpoint voltage of the rising edge of L2SYNC_IN to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 10).
4. The outputs are valid for both single-ended and differential L2CLK modes. For pipelined registered synchronous BurstRAMs, L2CR[14–15] = 01 or 10 is recommended. For pipelined late write synchronous BurstRAMs, L2CR[14–15] = 11 is recommended.
5. Guaranteed by design and characterization.
6. Revisions prior to Rev. 2.8 (Rev. E) were limited in performance and did not conform to this specification. For more information, refer to Section 10.2, “Part Numbers Not Fully Addressed by This Document.”

Figure 8 shows the L2 bus input timing diagrams for the MPC755.

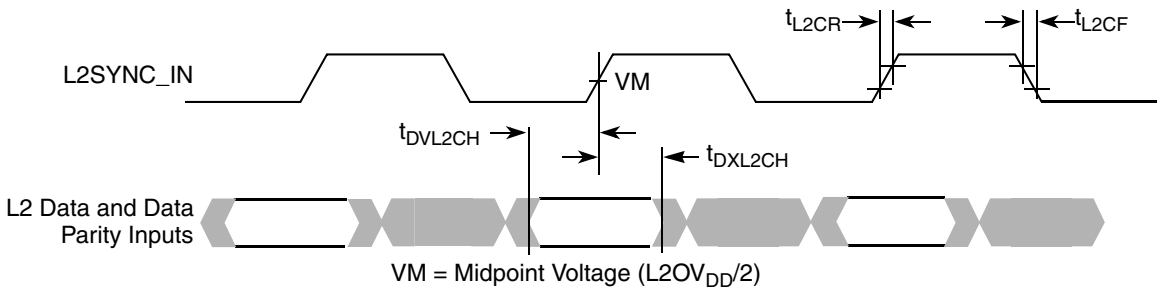


Figure 8. L2 Bus Input Timing Diagrams

4.2.5 IEEE 1149.1 AC Timing Specifications

Table 13 provides the IEEE 1149.1 (JTAG) AC timing specifications as defined in Figure 12 through Figure 15.

Table 13. JTAG AC Timing Specifications (Independent of SYSCLK) [1]

At recommended operating conditions (see Table 3)

Parameter		Symbol	Min	Max	Unit	Notes
TCK frequency of operation		f_{TCLK}	0	16	MHz	
TCK cycle time		t_{TCLK}	62.5	—	ns	
TCK clock pulse width measured at 1.4 V		t_{JHJL}	31	—	ns	
TCK rise and fall times		t_{JR}, t_{JF}	0	2	ns	
$\overline{\text{TRST}}$ assert time		t_{TRST}	25	—	ns	2
Input setup times:	Boundary-scan data TMS, TDI	t_{DVJH} t_{IVJH}	4 0	— —	ns	3
Input hold times:	Boundary-scan data TMS, TDI	t_{DXJH} t_{IXJH}	15 12	— —	ns	3
Valid times:	Boundary-scan data TDO	t_{JLDV} t_{JLOV}	— —	4 4	ns	4
Output hold times:	Boundary-scan data TDO	t_{JLDH} t_{JLOH}	25 12	— —	ns	4
TCK to output high impedance:	Boundary-scan data TDO	t_{JLDZ} t_{JLOZ}	3 3	19 9	ns	4, 5

Notes:

1. All outputs are measured from the midpoint voltage of the falling/rising edge of TCLK to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 11). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
2. $\overline{\text{TRST}}$ is an asynchronous level sensitive signal which must be asserted for this minimum time to be recognized.
3. Non-JTAG signal input timing with respect to TCK.
4. Non-JTAG signal output timing with respect to TCK.
5. Guaranteed by design and characterization.

Figure 11 provides the AC test load for TDO and the boundary-scan outputs of the MPC755.

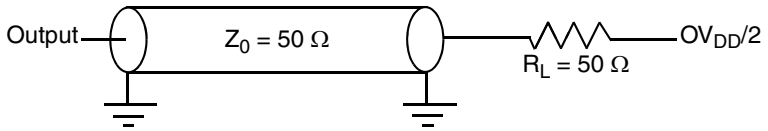


Figure 11. AC Test Load for the JTAG Interface

Figure 15 provides the test access port timing diagram.

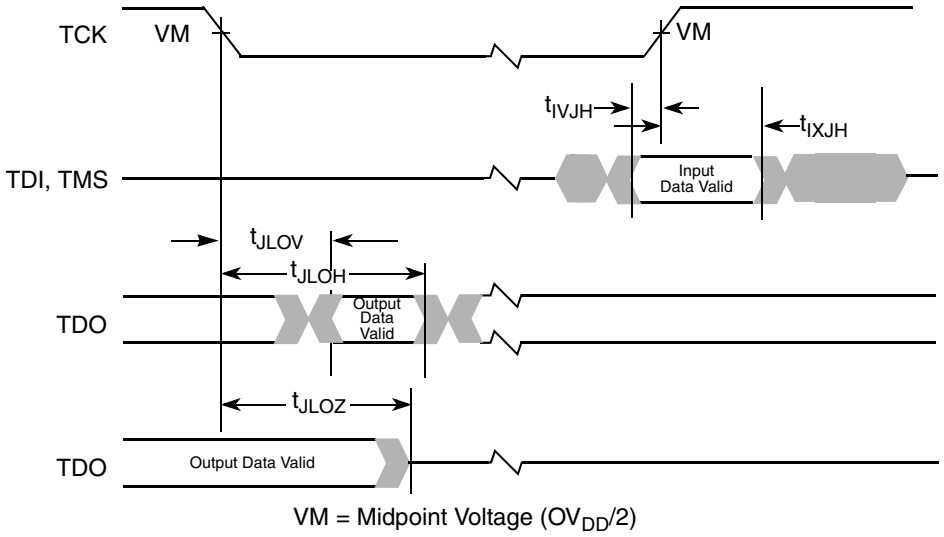
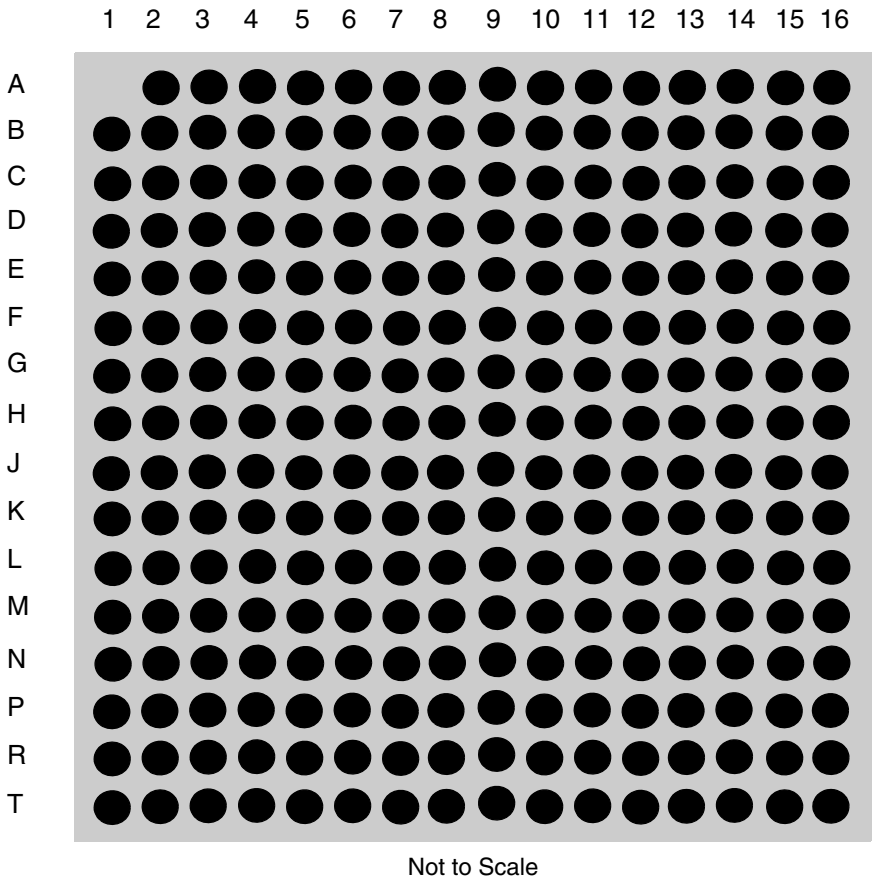


Figure 15. Test Access Port Timing Diagram

5 Pin Assignments

Figure 16 (in Part A) shows the pinout of the MPC745, 255 PBGA package as viewed from the top surface. Part B shows the side profile of the PBGA package to indicate the direction of the top surface view.

Part A



Part B

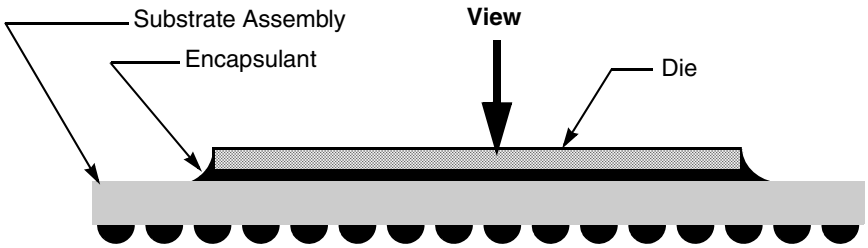
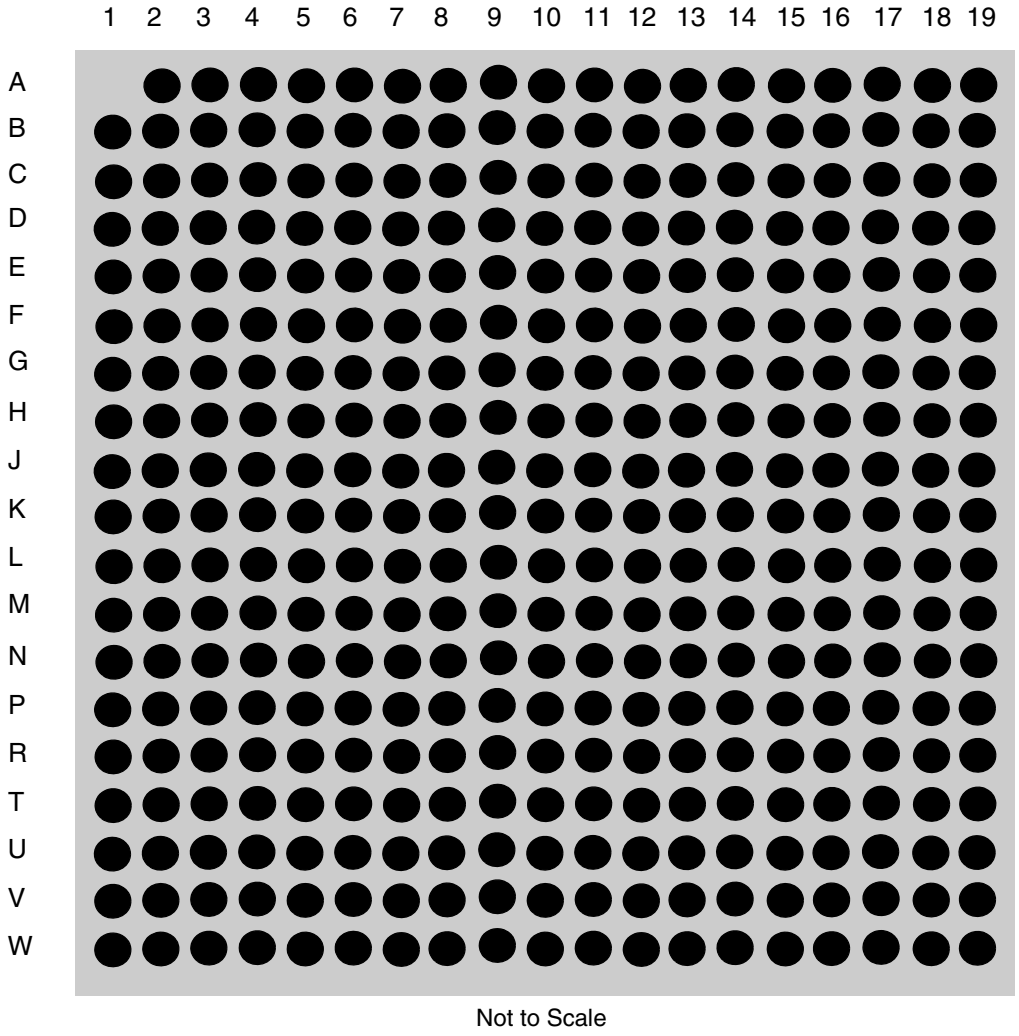


Figure 16. Pinout of the MPC745, 255 PBGA Package as Viewed from the Top Surface

Figure 17 (in Part A) shows the pinout of the MPC755, 360 PBGA and 360 CBGA packages as viewed from the top surface. Part B shows the side profile of the PBGA and CBGA package to indicate the direction of the top surface view.

Part A



Part B

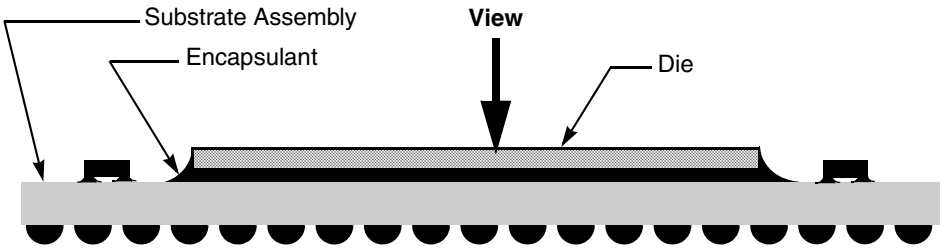


Figure 17. Pinout of the MPC755, 360 PBGA and CBGA Packages as Viewed from the Top Surface

Table 14. Pinout Listing for the MPC745, 255 PBGA Package (continued)

Signal Name	Pin Number	Active	I/O	I/F Voltage [1]	Notes
VOLTDET	F3	High	Output	—	6

Notes:

1. OV_{DD} supplies power to the processor bus, JTAG, and all control signals; and V_{DD} supplies power to the processor core and the PLL (after filtering to become AV_{DD}). These columns serve as a reference for the nominal voltage supported on a given signal as selected by the BVSEL pin configuration of Table 2 and the voltage supplied. For actual recommended value of V_{in} or supply voltages, see Table 3.
2. These are test signals for factory use only and must be pulled up to OV_{DD} for normal machine operation.
3. This pin must be pulled up to OV_{DD} for proper operation of the processor interface. To allow for future I/O voltage changes, provide the option to connect BVSEL independently to either OV_{DD} or GND.
4. Uses 1 of 15 existing no connects in the MPC740, 255 BGA package.
5. Internal pull-up on die.
6. Internally tied to GND in the MPC745, 255 BGA package to indicate to the power supply that a low-voltage processor is present. This signal is not a power supply input.

   Caution: This differs from the MPC755, 360 BGA package.

Table 15 provides the pinout listing for the MPC755, 360 PBGA and CBGA packages.

Table 15. Pinout Listing for the MPC755, 360 BGA Package

Signal Name	Pin Number	Active	I/O	I/F Voltage [1]	Notes
A[0:31]	A13, D2, H11, C1, B13, F2, C13, E5, D13, G7, F12, G3, G6, H2, E2, L3, G5, L4, G4, J4, H7, E1, G2, F3, J7, M3, H3, J2, J6, K3, K2, L2	High	I/O	OV_{DD}	
$\overline{\text{AACK}}$	N3	Low	Input	OV_{DD}	
$\overline{\text{ABB}}$	L7	Low	I/O	OV_{DD}	
AP[0:3]	C4, C5, C6, C7	High	I/O	OV_{DD}	
$\overline{\text{ARTRY}}$	L6	Low	I/O	OV_{DD}	
AV_{DD}	A8	—	—	2.0 V	
$\overline{\text{BG}}$	H1	Low	Input	OV_{DD}	
$\overline{\text{BR}}$	E7	Low	Output	OV_{DD}	
BVSEL	W1	High	Input	OV_{DD}	3, 5, 6
$\overline{\text{CI}}$	C2	Low	Output	OV_{DD}	
$\overline{\text{CKSTP\_IN}}$	B8	Low	Input	OV_{DD}	
$\overline{\text{CKSTP\_OUT}}$	D7	Low	Output	OV_{DD}	
CLK_OUT	E3	—	Output	OV_{DD}	
$\overline{\text{DBB}}$	K5	Low	I/O	OV_{DD}	
$\overline{\text{DBDIS}}$	G1	Low	Input	OV_{DD}	
$\overline{\text{DBG}}$	K1	Low	Input	OV_{DD}	
$\overline{\text{DBWO}}$	D1	Low	Input	OV_{DD}	

Table 15. Pinout Listing for the MPC755, 360 BGA Package (continued)

Signal Name	Pin Number	Active	I/O	I/F Voltage [1]	Notes
DH[0:31]	W12, W11, V11, T9, W10, U9, U10, M11, M9, P8, W7, P9, W9, R10, W6, V7, V6, U8, V9, T7, U7, R7, U6, W5, U5, W4, P7, V5, V4, W3, U4, R5	High	I/O	OV_{DD}	
DL[0:31]	M6, P3, N4, N5, R3, M7, T2, N6, U2, N7, P11, V13, U12, P12, T13, W13, U13, V10, W8, T11, U11, V12, V8, T1, P1, V1, U1, N1, R2, V3, U3, W2	High	I/O	OV_{DD}	
DP[0:7]	L1, P2, M2, V2, M1, N2, T3, R1	High	I/O	OV_{DD}	
$\overline{\text{DRTRY}}$	H6	Low	Input	OV_{DD}	
$\overline{\text{GBL}}$	B1	Low	I/O	OV_{DD}	
GND	D10, D14, D16, D4, D6, E12, E8, F4, F6, F10, F14, F16, G9, G11, H5, H8, H10, H12, H15, J9, J11, K4, K6, K8, K10, K12, K14, K16, L9, L11, M5, M8, M10, M12, M15, N9, N11, P4, P6, P10, P14, P16, R8, R12, T4, T6, T10, T14, T16	—	—	GND	
$\overline{\text{HRESET}}$	B6	Low	Input	OV_{DD}	
$\overline{\text{INT}}$	C11	Low	Input	OV_{DD}	
L1_TSTCLK	F8	High	Input	—	2
L2ADDR[16:0]	G18, H19, J13, J14, H17, H18, J16, J17, J18, J19, K15, K17, K18, M19, L19, L18, L17	High	Output	$L2OV_{DD}$	
$L2AV_{DD}$	L13	—	—	2.0 V	
$\overline{\text{L2CE}}$	P17	Low	Output	$L2OV_{DD}$	
L2CLK_OUTA	N15	—	Output	$L2OV_{DD}$	
L2CLK_OUTB	L16	—	Output	$L2OV_{DD}$	
L2DATA[0:63]	U14, R13, W14, W15, V15, U15, W16, V16, W17, V17, U17, W18, V18, U18, V19, U19, T18, T17, R19, R18, R17, R15, P19, P18, P13, N14, N13, N19, N17, M17, M13, M18, H13, G19, G16, G15, G14, G13, F19, F18, F13, E19, E18, E17, E15, D19, D18, D17, C18, C17, B19, B18, B17, A18, A17, A16, B16, C16, A14, A15, C15, B14, C14, E13	High	I/O	$L2OV_{DD}$	
L2DP[0:7]	V14, U16, T19, N18, H14, F17, C19, B15	High	I/O	$L2OV_{DD}$	
$L2OV_{DD}$	D15, E14, E16, H16, J15, L15, M16, P15, R14, R16, T15, F15	—	—	$L2OV_{DD}$	
L2SYNC_IN	L14	—	Input	$L2OV_{DD}$	
L2SYNC_OUT	M14	—	Output	$L2OV_{DD}$	
L2_TSTCLK	F7	High	Input	—	2
L2VSEL	A19	High	Input	$L2OV_{DD}$	1, 5, 6, 7
$\overline{\text{L2WE}}$	N16	Low	Output	$L2OV_{DD}$	

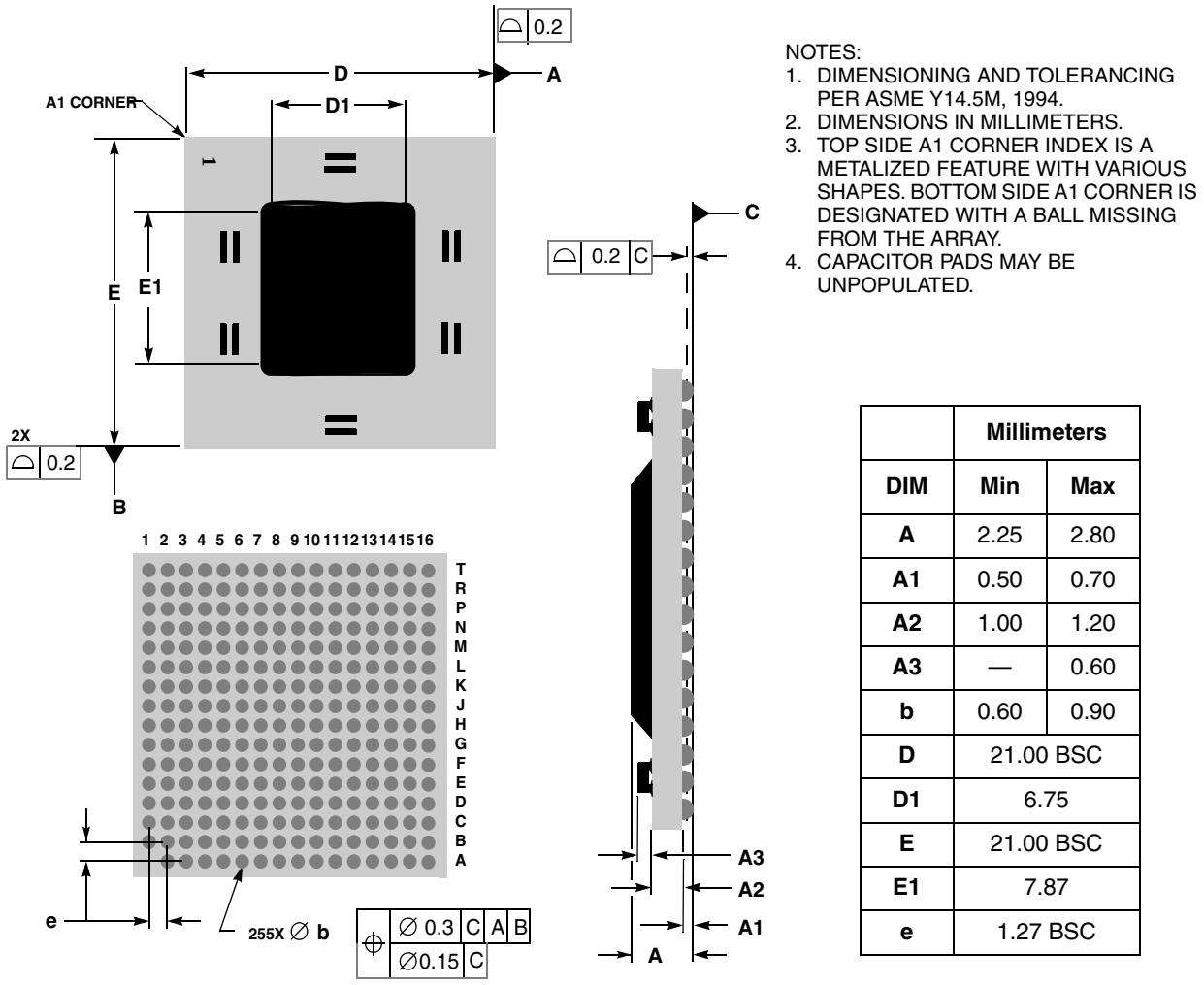
7.1 Package Parameters for the MPC745 PBGA

The package parameters are as provided in the following list. The package type is 21 × 21 mm, 255-lead plastic ball grid array (PBGA).

Package outline	21 × 21 mm
Interconnects	255 (16 × 16 ball array – 1)
Pitch	1.27 mm (50 mil)
Minimum module height	2.25 mm
Maximum module height	2.80 mm
Ball diameter (typical)	0.75 mm (29.5 mil)

7.2 Mechanical Dimensions for the MPC745 PBGA

Figure 18 provides the mechanical dimensions and bottom surface nomenclature for the MPC745, 255 PBGA package.



	Millimeters	
DIM	Min	Max
A	2.25	2.80
A1	0.50	0.70
A2	1.00	1.20
A3	—	0.60
b	0.60	0.90
D	21.00 BSC	
D1	6.75	
E	21.00 BSC	
E1	7.87	
e	1.27 BSC	

Figure 18. Mechanical Dimensions and Bottom Surface Nomenclature for the MPC745, 255 PBGA Package

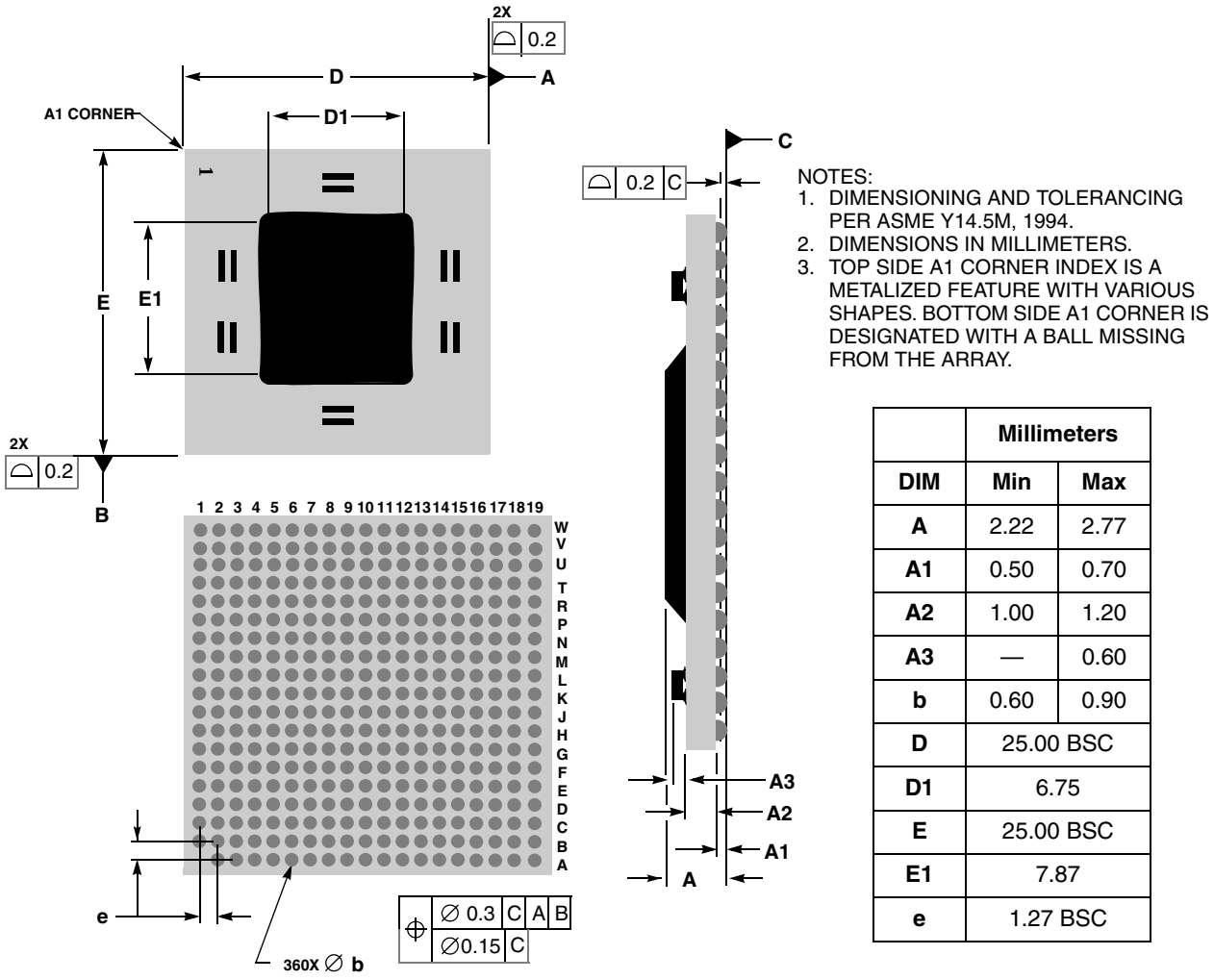
7.5 Package Parameters for the MPC755 PBGA

The package parameters are as provided in the following list. The package type is 25 × 25 mm, 360-lead plastic ball grid array (PBGA).

Package outline	25 × 25 mm
Interconnects	360 (19 × 19 ball array – 1)
Pitch	1.27 mm (50 mil)
Minimum module height	2.22 mm
Maximum module height	2.77 mm
Ball diameter	0.75 mm (29.5 mil)

7.6 Mechanical Dimensions for the MPC755

Figure 20 provides the mechanical dimensions and bottom surface nomenclature for the MPC755, 360 PBGA package.



	Millimeters	
DIM	Min	Max
A	2.22	2.77
A1	0.50	0.70
A2	1.00	1.20
A3	—	0.60
b	0.60	0.90
D	25.00 BSC	
D1	6.75	
E	25.00 BSC	
E1	7.87	
e	1.27 BSC	

Figure 20. Mechanical Dimensions and Bottom Surface Nomenclature for the MPC755, 360 PBGA Package

8 System Design Information

This section provides electrical and thermal design recommendations for successful application of the MPC755.

8.1 PLL Configuration

The MPC755 PLL is configured by the PLL_CFG[0:3] signals. For a given SYSCLK (bus) frequency, the PLL configuration signals set the internal CPU and VCO frequency of operation. These must be chosen such that they comply with Table 8. Table 16 shows the valid configurations of these signals and an example illustrating the core and VCO frequencies resulting from various PLL configurations and example bus frequencies. In this example, shaded cells represent settings that, for a given SYSCLK frequency, result in core and/or VCO frequencies that do not comply with the 400-MHz column in Table 8.

Table 16. MPC755 Microprocessor PLL Configuration Example for 400 MHz Parts

PLL_CFG [0:3]	Example Bus-to-Core Frequency in MHz (VCO Frequency in MHz)							
	Bus-to-Core Multiplier	Core-to-VCO Multiplier	Bus 33 MHz	Bus 50 MHz	Bus 66 MHz	Bus 75 MHz	Bus 80 MHz	Bus 100 MHz
0100	2x	2x	—	—	—	—	—	200 (400)
1000	3x	2x	—	—	200 (400)	225 (450)	240 (480)	300 (600)
1110	3.5x	2x	—	—	233 (466)	263 (525)	280 (560)	350 (700)
1010	4x	2x	—	200 (400)	266 (533)	300 (600)	320 (640)	400 (800)
0111	4.5x	2x	—	225 (450)	300 (600)	338 (675)	360 (720)	—
1011	5x	2x	—	250 (500)	333 (666)	375 (750)	400 (800)	—
1001	5.5x	2x	—	275 (550)	366 (733)	—	—	—
1101	6x	2x	200 (400)	300 (600)	400 (800)	—	—	—
0101	6.5x	2x	216 (433)	325 (650)	—	—	—	—
0010	7x	2x	233 (466)	350 (700)	—	—	—	—
0001	7.5x	2x	250 (500)	375 (750)	—	—	—	—
1100	8x	2x	266 (533)	400 (800)	—	—	—	—
0110	10x	2x	333 (666)	—	—	—	—	—

Table 16. MPC755 Microprocessor PLL Configuration Example for 400 MHz Parts (continued)

PLL_CFG [0:3]	Example Bus-to-Core Frequency in MHz (VCO Frequency in MHz)							
	Bus-to-Core Multiplier	Core-to-VCO Multiplier	Bus 33 MHz	Bus 50 MHz	Bus 66 MHz	Bus 75 MHz	Bus 80 MHz	Bus 100 MHz
0011	PLL off/bypass		PLL off, SYSCLK clocks core circuitry directly, 1x bus-to-core implied					
1111	PLL off		PLL off, no core clocking occurs					

Notes:

1. PLL_CFG[0:3] settings not listed are reserved.
2. The sample bus-to-core frequencies shown are for reference only. Some PLL configurations may select bus, core, or VCO frequencies which are not useful, not supported, or not tested for by the MPC755; see Section 4.2.1, "Clock AC Specifications," for valid SYSCLK, core, and VCO frequencies.
3. In PLL-bypass mode, the SYSCLK input signal clocks the internal processor directly, the PLL is disabled, and the bus mode is set for 1:1 mode operation. This mode is intended for factory use and emulator tool use only.
   Note: The AC timing specifications given in this document do not apply in PLL-bypass mode.
4. In PLL off mode, no clocking occurs inside the MPC755 regardless of the SYSCLK input.

The MPC755 generates the clock for the external L2 synchronous data SRAMs by dividing the core clock frequency of the MPC755. The divided-down clock is then phase-adjusted by an on-chip delay-lock-loop (DLL) circuit and should be routed from the MPC755 to the external RAMs. A separate clock output, L2SYNC_OUT is sent out half the distance to the SRAMs and then returned as an input to the DLL on pin L2SYNC_IN so that the rising-edge of the clock as seen at the external RAMs can be aligned to the clocking of the internal latches in the L2 bus interface.

The core-to-L2 frequency divisor for the L2 PLL is selected through the L2CLK bits of the L2CR register. Generally, the divisor must be chosen according to the frequency supported by the external RAMs, the frequency of the MPC755 core, and the phase adjustment range that the L2 DLL supports. Table 17 shows various example L2 clock frequencies that can be obtained for a given set of core frequencies. The minimum L2 frequency target is 80 MHz.

Table 17. Sample Core-to-L2 Frequencies

Core Frequency (MHz)	÷1	÷1.5	÷2	÷2.5	÷3
250	250	166	125	100	83
266	266	177	133	106	89
275	275	183	138	110	92
300	300	200	150	120	100
325	325	217	163	130	108
333	333	222	167	133	111
350	350	233	175	140	117
366	366	244	183	146	122

Table 18 summarizes the signal impedance results. The driver impedance values were characterized at 0°, 65°, and 105°C. The impedance increases with junction temperature and is relatively unaffected by bus voltage.

Table 18. Impedance Characteristics

V_{DD} = 2.0 V, OV_{DD} = 3.3 V, T_j = 0°–105°C

Impedance	Processor Bus	L2 Bus	Symbol	Unit
R_N	25–36	25–36	Z_0	Ω
R_P	26–39	26–39	Z_0	Ω

8.6 Pull-Up Resistor Requirements

The MPC755 requires pull-up resistors (1–5 kΩ) on several control pins of the bus interface to maintain the control signals in the negated state after they have been actively negated and released by the MPC755 or other bus masters. These pins are $\overline{TS}$, $\overline{ABB}$, $\overline{AACK}$, $\overline{ARTRY}$, $\overline{DBB}$, $\overline{DBWO}$, $\overline{TA}$, $\overline{TEA}$, and $\overline{DBDIS}$. $\overline{DRTRY}$ should also be connected to a pull-up resistor (1–5 kΩ) if it will be used by the system; otherwise, this signal should be connected to $\overline{HRESET}$ to select NO-DRTRY mode (see the *MPC750 RISC Microprocessor Family User's Manual* for more information on this mode).

Three test pins also require pull-up resistors (100 Ω–1 kΩ). These pins are L1_TSTCLK, L2_TSTCLK, and $\overline{LSSD\_MODE}$. These signals are for factory use only and must be pulled up to OV_{DD} for normal machine operation.

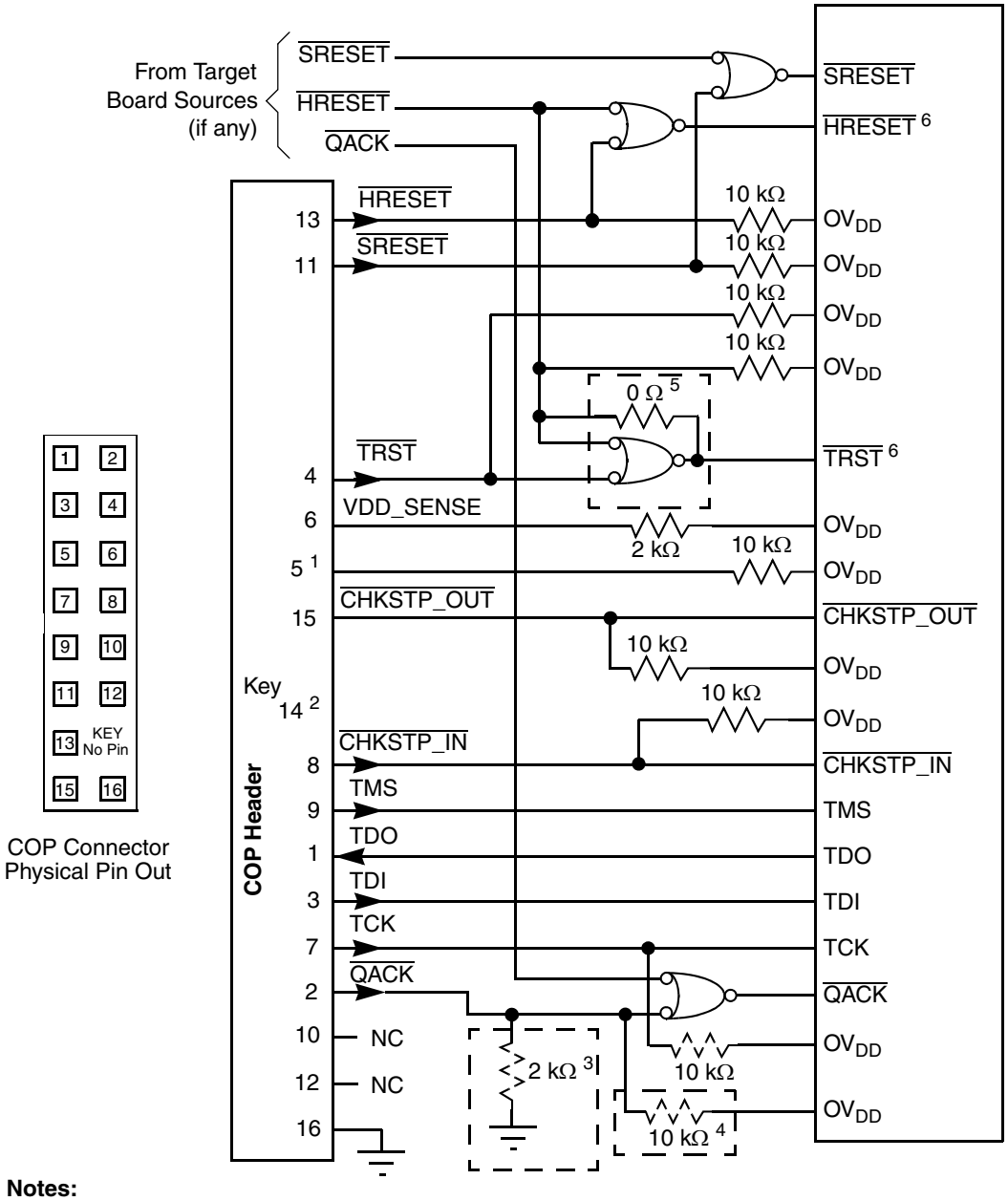
In addition, $\overline{CKSTP\_OUT}$ is an open-drain style output that requires a pull-up resistor (1–5 kΩ) if it is used by the system.

During inactive periods on the bus, the address and transfer attributes may not be driven by any master and may, therefore, float in the high-impedance state for relatively long periods of time. Since the MPC755 must continually monitor these signals for snooping, this float condition may cause additional power draw by the input receivers on the MPC755 or by other receivers in the system. These signals can be pulled up through weak (10-kΩ) pull-up resistors by the system or may be otherwise driven by the system during inactive periods of the bus to avoid this additional power draw, but address bus pull-up resistors are not necessary for proper device operation. The snooped address and transfer attribute inputs are: A[0:31], AP[0:3], TT[0:4], $\overline{TBST}$, and $\overline{GBL}$.

The data bus input receivers are normally turned off when no read operation is in progress and, therefore, do not require pull-up resistors on the bus. Other data bus receivers in the system, however, may require pull-ups, or that those signals be otherwise driven by the system during inactive periods by the system. The data bus signals are: DH[0:31], DL[0:31], and DP[0:7].

If 32-bit data bus mode is selected, the input receivers of the unused data and parity bits will be disabled, and their outputs will drive logic zeros when they would otherwise normally be driven. For this mode, these pins do not require pull-up resistors, and should be left unconnected by the system to minimize possible output switching.

If address or data parity is not used by the system, and the respective parity checking is disabled through HID0, the input receivers for those pins are disabled, and those pins do not require pull-up resistors and



Notes:

1. RUN/$\overline{\text{STOP}}$, normally found on pin 5 of the COP header, is not implemented on the MPC755. Connect pin 5 of the COP header to OV_{DD} with a 10-kΩ pull-up resistor.
2. Key location; pin 14 is not physically present on the COP header.
3. Component not populated. Populate only if debug tool does not drive $\overline{\text{QACK}}$.
4. Populate only if debug tool uses an open-drain type output and does not actively deassert $\overline{\text{QACK}}$.
5. If the JTAG interface is implemented, connect $\overline{\text{HRESET}}$ from the target source to $\overline{\text{TRST}}$ from the COP header though an AND gate to $\overline{\text{TRST}}$ of the part. If the JTAG interface is not implemented, connect $\overline{\text{HRESET}}$ from the target source to $\overline{\text{TRST}}$ of the part through a 0-Ω isolation resistor.
6. The COP port and target board should be able to independently assert $\overline{\text{HRESET}}$ and $\overline{\text{TRST}}$ to the processor in order to fully control the processor as shown above.

Figure 24. JTAG Interface Connection

9 Document Revision History

Table 19 provides a revision history for this hardware specification.

Table 19. Document Revision History

Revision	Date	Substantive Change(s)
8	2/8/2006	Changed processor descriptor from ‘B’ to ‘C’ for 350 MHz devices and increased power specifications for full-power mode in Table 7.
7	4/05/2005	Removed phrase “for the ceramic ball grid array (CBGA) package” from Section 8.8; this information applies to devices in both CBGA and PBGA packages.
		Figure 24—updated COP Connector Diagram to recommend a weak pull-up resistor on TCK.
		Table 20—added MPC745BPXLE, MPC755BRXLE, MPC755BPXLE, MPC755CVTLE, MPC755BVTLE and MPC745BVTLE part numbers. These devices are fully addressed by this document.
		Corrected Revision Level in Table 23: Rev E devices are Rev 2.8, not 2.7.
		Added MPC755CRX400LE and MPC755CPX400LE to devices supported by this specification in Table 20.
		Removed “Advance Information” from title block on page 1.
6.1	1/21/2005	Updated document template.
6	—	Removed 450 MHz speed grade throughout document. These devices are no longer supported for new designs; see Section 1.10.2 for more information.
		Relaxed voltage sequencing requirements in Notes 3 and 4 of Table 1.
		Corrected Note 2 of Table 7.
		Changed processor descriptor from ‘B’ to ‘C’ for 400 MHz devices and increased power specifications for full-power mode in Table 7. XPC755Bxx400LE devices are no longer produced and are documented in a separate part number specification; see Section 1.10.2 for more information.
		Increased power specifications for sleep mode for all speed grades in Table 7.
		Removed ‘Sleep Mode (PLL and DLL Disabled)—Typical’ specification from Table 7; this is no longer tested or characterized.
		Added Note 4 to Table 7.
		Revised L2 clock duty cycle specification in Table 11 and changed Note 7.
		Corrected Note 3 in Table 20.
		Replaced Table 21 and added Tables 22 and 23.
5	—	Added Note 6 to Table 10; clarification only as this information is already documented in the *MPC750 RISC Microprocessor Family User’s Manual*.
		Revised Figure 24 and Section 1.8.7.
		Corrected Process Identifier for 450 MHz part in Table 20.
		Added XPC755BRX*nnn*T*x* series to Table 21.